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M. Brunson
7/17/01

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent application of

Kazuki Yokato

Serial No.: 09/627,456

Filing Date: July 27, 2000



Group Art Unit: 2877

Examiner: Unknown

For: OVERLAY MARK, METHOD OF MEASURING OVERLAY ACCURACY, METHOD
OF MAKING ALIGNMENT AND SEMICONDUCTOR DEVICE THEREWITH

Assistant Commissioner of Patents
Washington, D.C. 20231

NOTICE OF CHANGE OF ADDRESS

Sir:

Please be advised that the correspondence address of attorneys of record in the above-identified application has been changed to:

McGinn & Gibb, PLLC
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Please change the records in regard to the above-identified application accordingly and direct all telephone calls to the number shown above.

Respectfully submitted,

A handwritten signature in black ink, appearing to read "Sean M. McGinn".

Sean M. McGinn
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Date: 7/9/01
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